

Features

- N-channel, normal level
- Excellent FOM
- Very low on-resistance $R_{DS(on)}$
- Ideal for high-frequency switching and synchronous rectification
- Pb-free lead plating; RoHS compliant

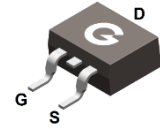
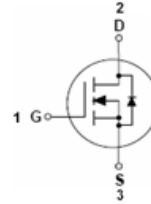
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Key performance parameters

Parameter	Value	Unit
V_{DS}	100	V
$R_{DS(on), max@10V}$	4.5	m Ω
$Q_{g, typ @10V}$	105	nC

Mechanical Data

- Case: TO-263
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



TO-263

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL045N10THB	TO-263	50 pcs / Tube & 800 pcs / Tape & Reel	045N10THB

Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	100	V
Gate-to-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current ($T_C = 25^\circ\text{C}$, Silicon limited) *1	I_D	110	A
Continuous Drain Current ($T_C = 100^\circ\text{C}$, Silicon limited)		70	A
Pulsed Drain Current ($t_p = 10\mu\text{s}$)*1	I_{DM}	645	A
Single Pulse Avalanche Energy *4	E_{AS}	560	mJ

Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	178	W
Thermal Resistance Junction-to-Air *2	$R_{\theta JA}$	62	$^\circ\text{C}/\text{W}$
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	0.7	$^\circ\text{C}/\text{W}$
Operating Junction Temperature Range	T_J	-55 ~ +150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55 ~ +150	$^\circ\text{C}$

Electrical Characteristics (@ T_A = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 1mA	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
R _{DS(ON)}	Static Drain-Source On-resistance ^{*2}	V _{GS} = 10V, I _D = 100A	-	3.5	4.5	mΩ
		V _{GS} = 6V, I _D = 50A	-	5	7.4	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 150μA	2	2.9	4	V
R _G	Gate resistance	-	-	2.6	-	Ω
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V V _{DS} = 50V f = 1.0MHz	-	6998	8410	pF
C _{OSS}	Output Capacitance		-	892	1610	
C _{RSS}	Reverse Transfer Capacitance		-	40	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} = 50V V _{GS} = 10V R _G = 1.6Ω I _D = 50A	-	35	-	ns
t _r	Turn-on Rise Time		-	18	-	
t _{d(OFF)}	Turn-Off Delay Time		-	45	-	
t _f	Turn-Off Fall Time		-	55	-	
Gate charge characteristics						
Q _G	Total Gate-Charge	V _{DD} = 50V I _D = 100A V _{GS} = 10V	-	105	-	nC
Q _{GS}	Gate to Source Charge		-	36.1	-	
Q _{GD}	Gate to Drain (Miller) Charge		-	24.6	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage ^{*3}	I _{SD} = 10A, V _{GS} = 0V	-	1.0	1.2	V
I _{SD}	Diode Continuous Forward Current ^{*5}	T _C = 25°C	-	-	137	A
I _{SD, pulse}	Diode Pulse current	T _C = 25°C	-	-	548	A
t _{rr}	Reverse recovery time	V _R = 50V I _F = 30A, di/dt = 100A/us,	-	155	-	ns
Q _{rr}	Reverse recovery charge		-	390	-	nC
I _{RRM}	Reverse recovery current		-	4.7	-	A

Notes:

- See fig.11
- The data tested by surface mounted on 1 inch² FR-4 board with 2OZ copper
- The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
- The E_{AS} data shows Max. rating. The test condition is V_{DD} = 50V, V_{GS} = 10V, L = 1mH
- The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

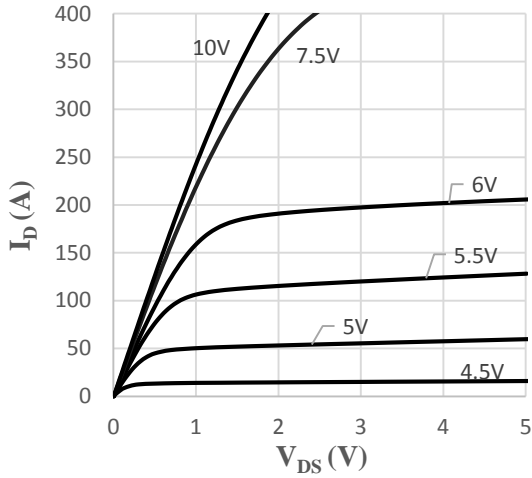


Fig 1 Typical Output Characteristics

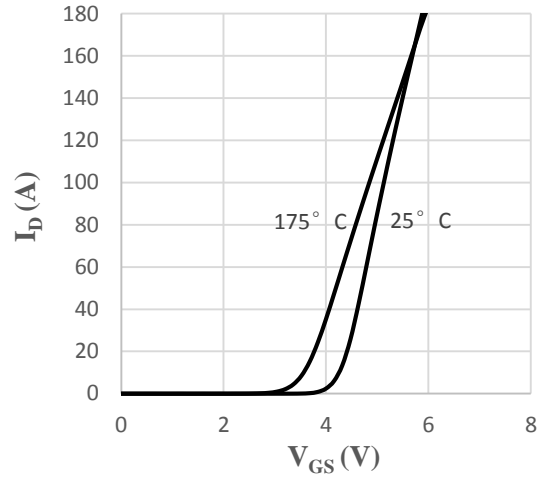


Fig 2 Transfer Characteristics

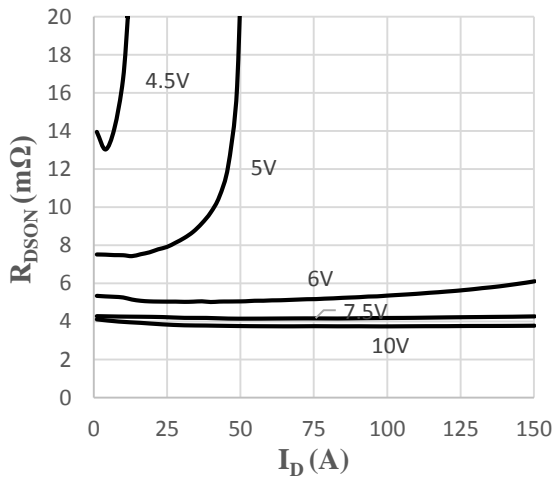


Fig 3 Drain-source on resistance

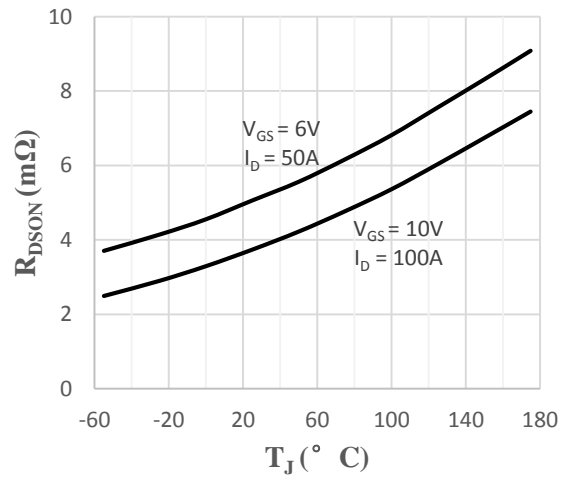


Fig 4 On-Resistance vs. Junction Temperature

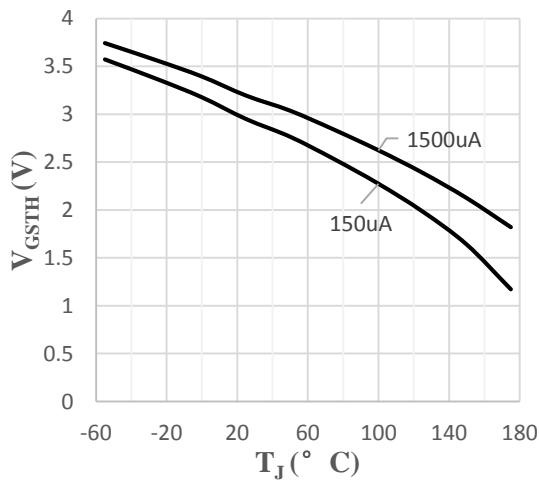


Fig 5 Gate Voltage vs. Junction Temp

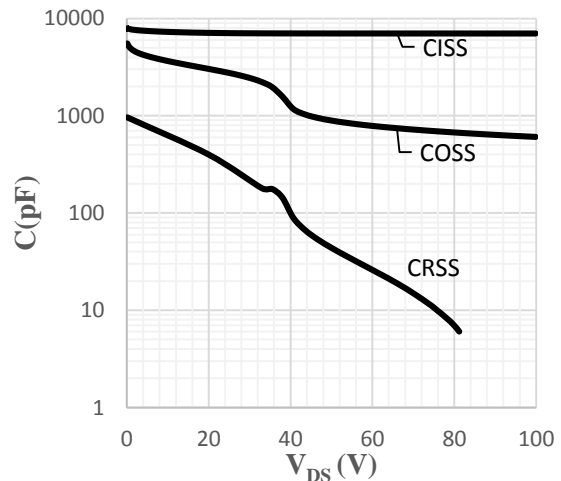


Fig 6 Capacitance Characteristics

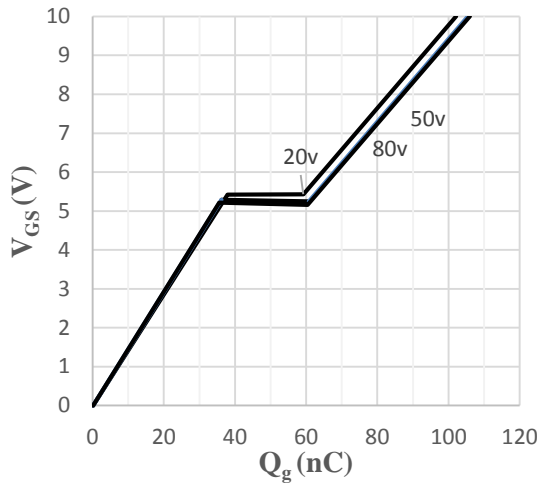


Fig 7 Gate-Charge Characteristics

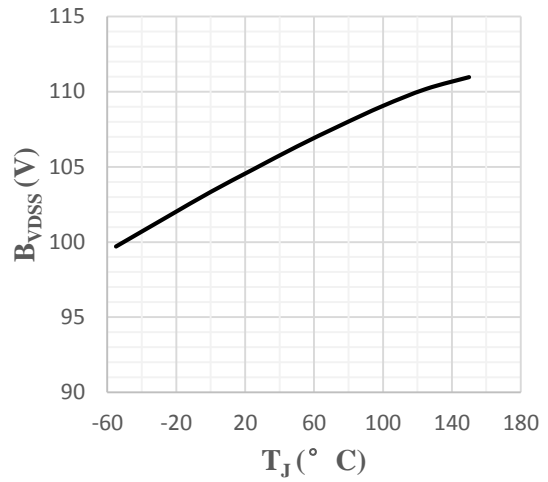


Fig 8 Drain-Source breakdown voltage

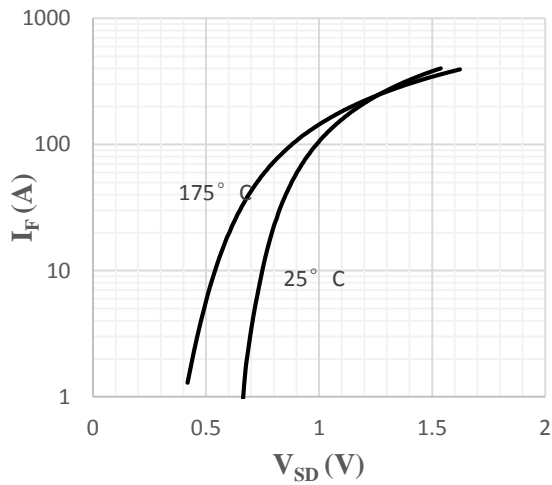


Fig 9 Forward characteristics of reverse diode

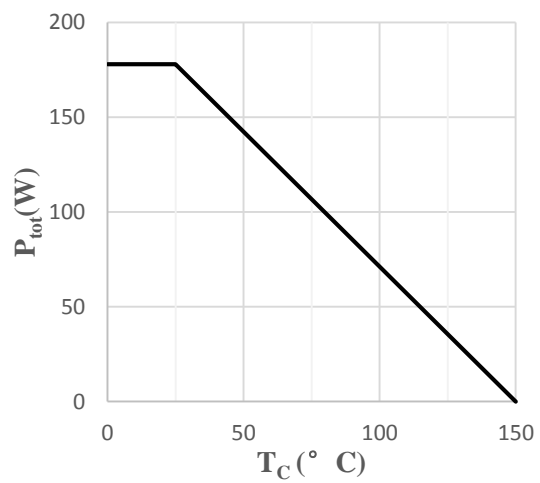


Fig 10 Power dissipation

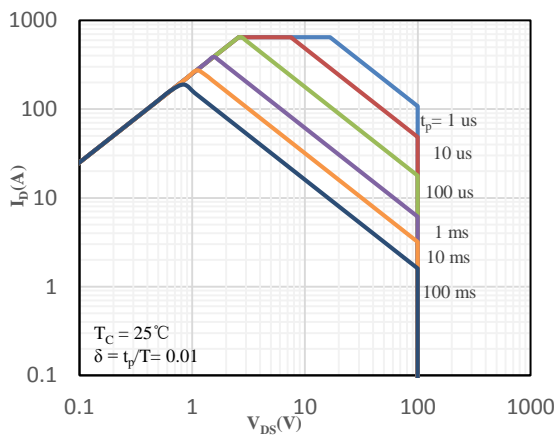


Fig 11 Safe operating area

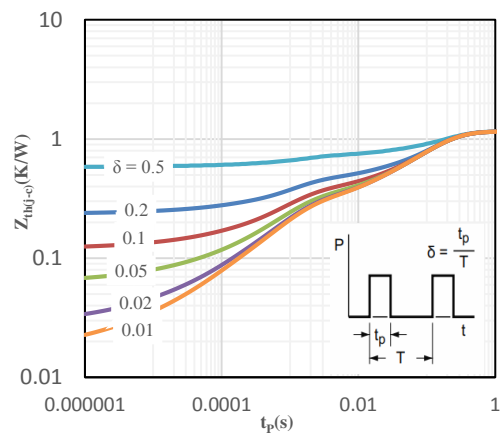
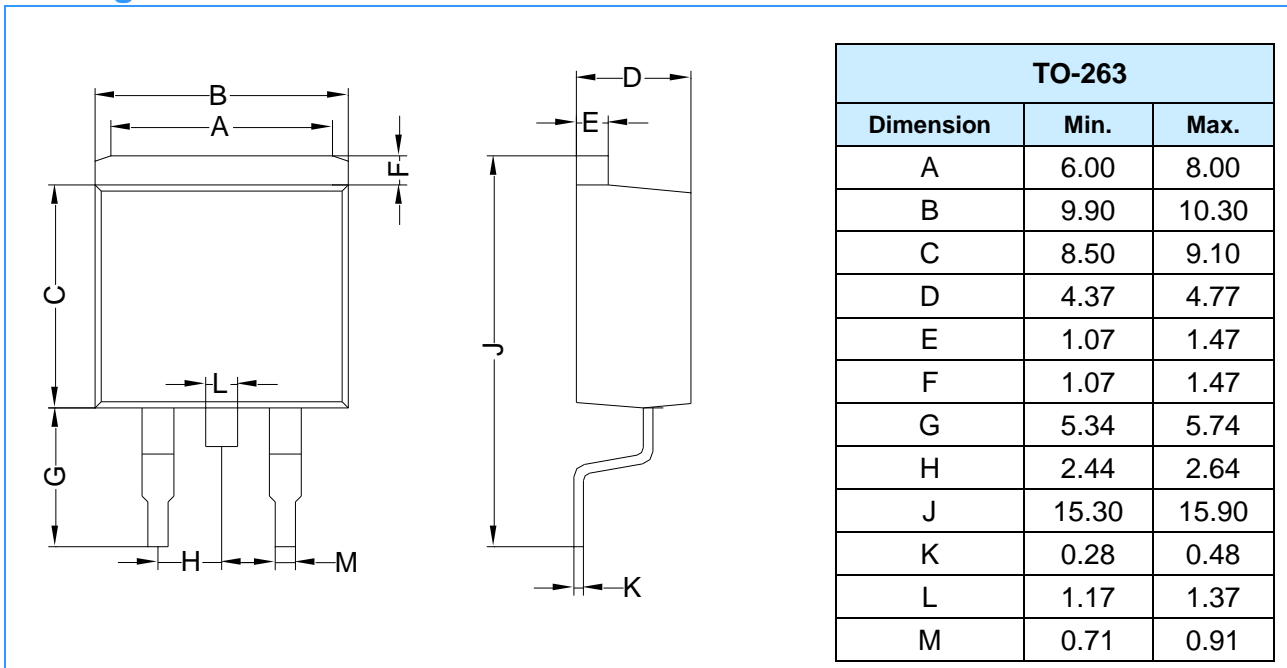
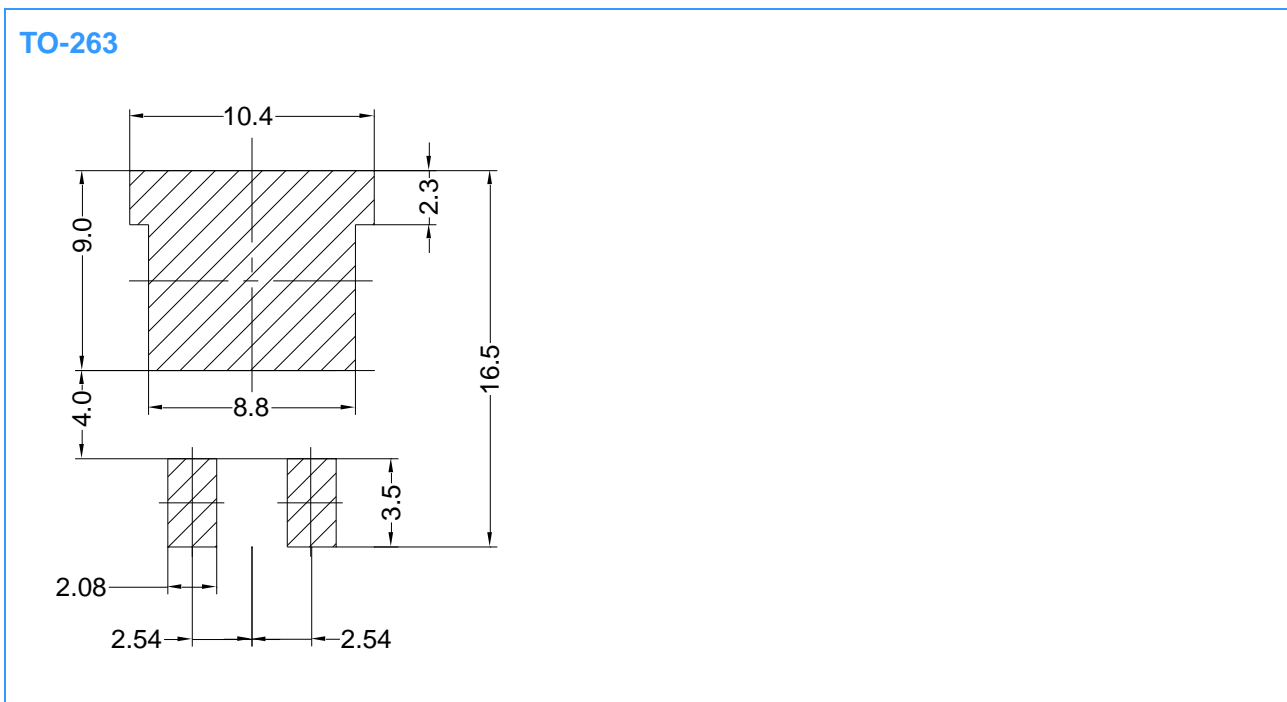


Fig 12 transient thermal impedance

Package Outline Dimensions (Unit: mm)



Mounting Pad Layout (Unit: mm)



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